



Euclid TechLabs LLC



# DEVELOPMENT OF DIELECTRIC-BASED HIGH GRADIENT ACCELERATING STRUCTURES

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# OUTLINE

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1. The Recent High Power rf Testing of Quartz Based DLA Structure
2. Ways to Higher Gradient for DLA Structures
  - small I.D. quartz DLA structure design: Test high gradient and multipactor power scaling
  - Gapless DLA structure based on the new coupler design
  - Low loss double layer DLA structure



# Part I

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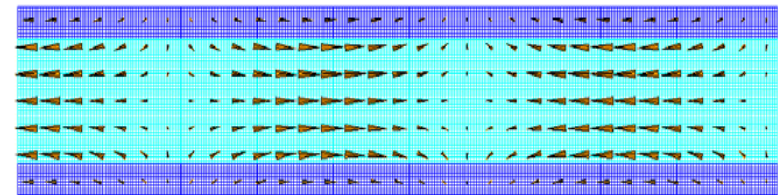
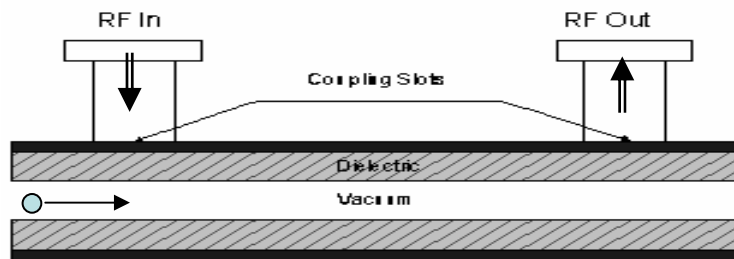
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# High Power RF Testing of The Quartz Based DLA Structure (I)

-----Introduction

- Dielectric-Loaded Accelerating (DLA) structure is a potentially candidate for the high gradient accelerator in the future.



- DLA Structure Development:

- **1) Coupler Breakdown** (cured)
- **2) Multipactor** (Anomalous Power Absorption)
- **3) Joint Breakdown** at the dielectric gap.
- **4) Tested Materials: MgCaTiO<sub>3</sub>, Alumina, TiN coated Alumina**

- Motivation for Quartz Test: to test the multipactor effect of the different material due to quartz has relatively low secondary electron yield.

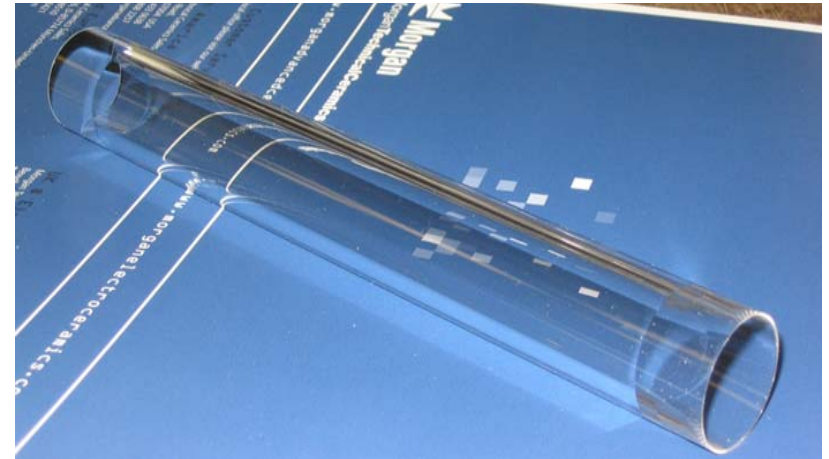


# High Power RF Testing of The Quartz Based DLA Structure (II)

## -----Design & Fabrication

Parameters	Value
Material	Fused Silicon
Inner Radius	8.97mm
Outer Radius	12.08mm
Dielectric Const	3.78
Group Velocity	0.38c
R/Q	3.614k $\Omega$ /m
Shunt Impedance	27.9 M $\Omega$ /m *
Q	7715*
Power ATTN	0.35dB/m*
RF power needed to support 1MV/m gradient	439kW

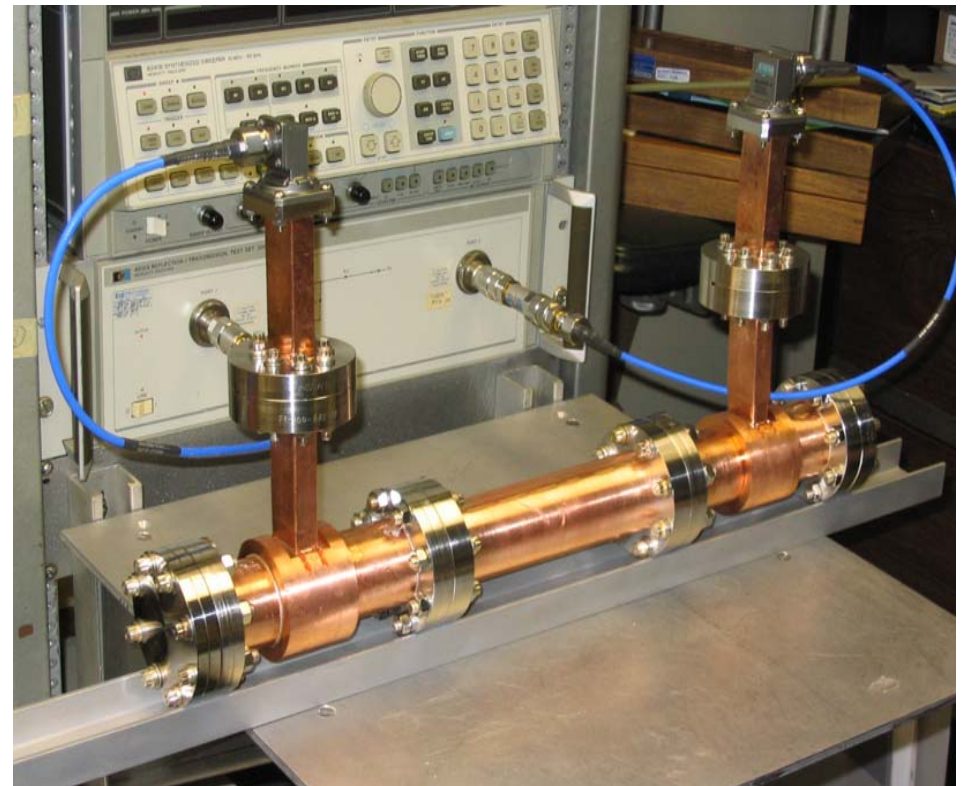
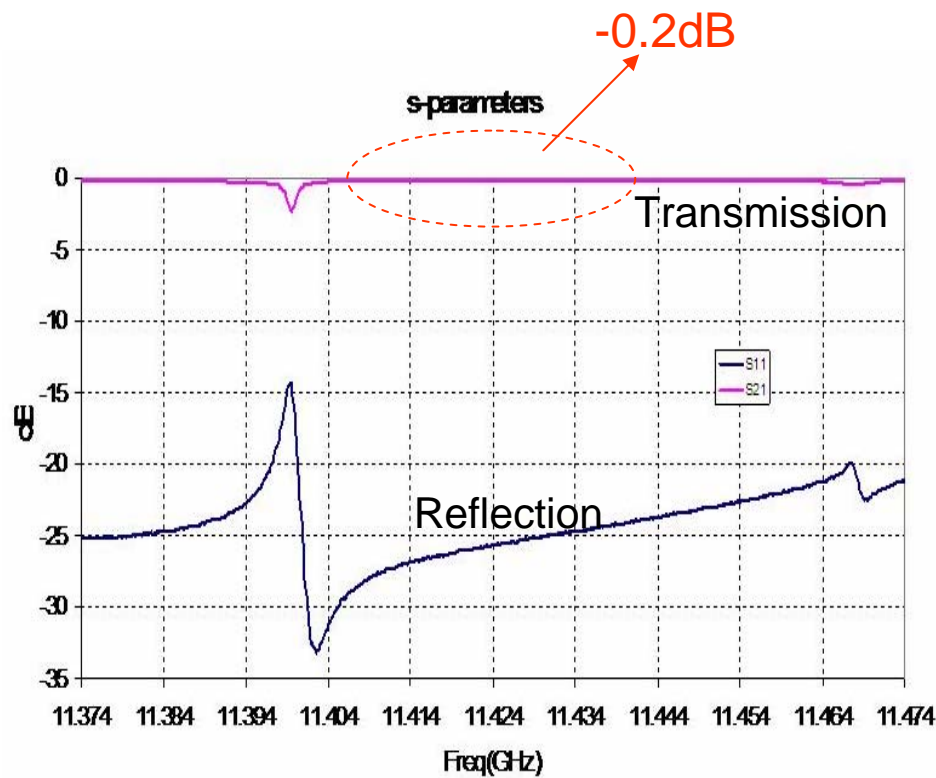
\*Loss tangent of the dielectrics is  $2 \times 10^{-5}$ .



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# High Power RF Testing of The Quartz Based DLA Structure (III)

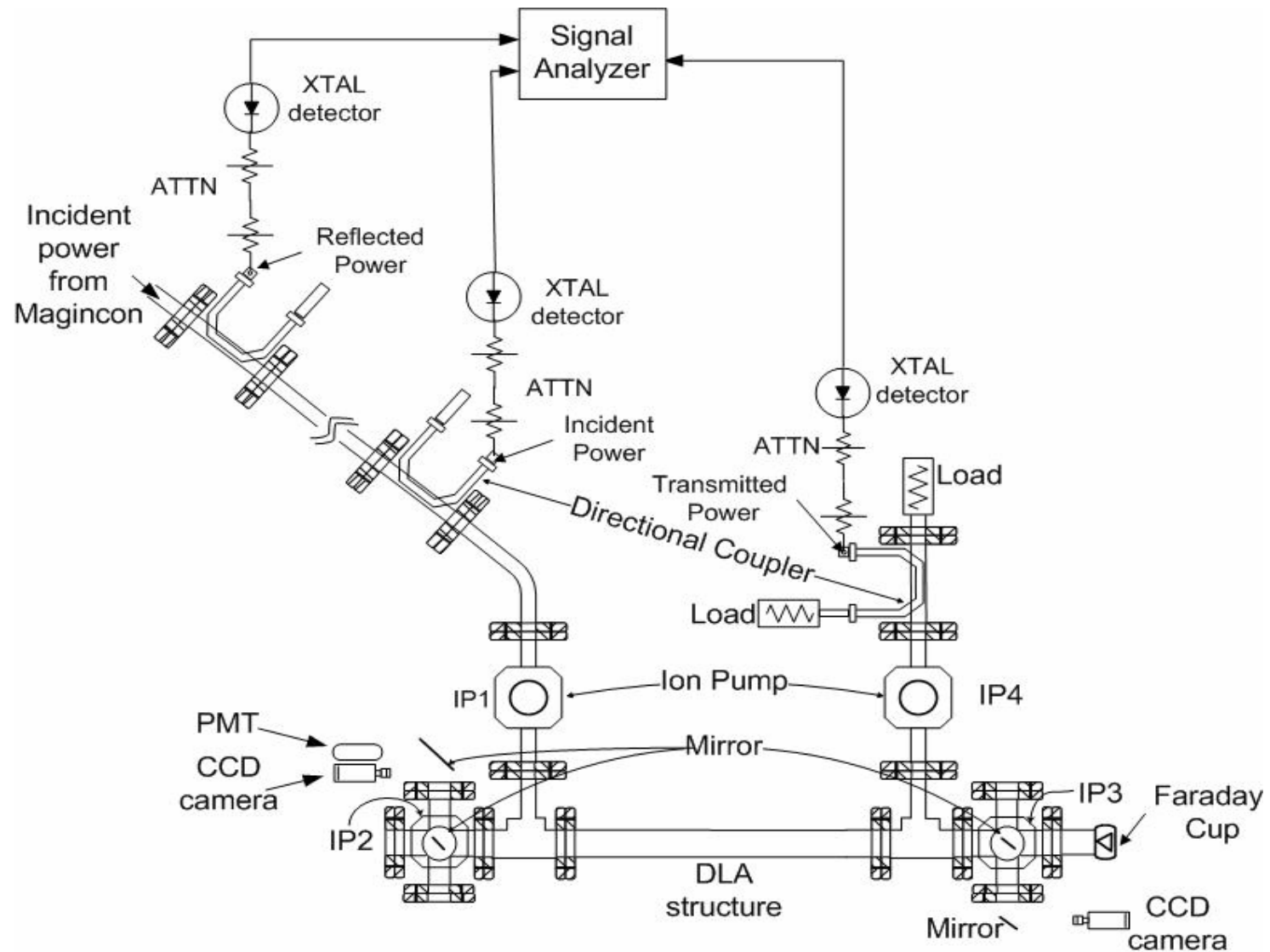
-----Bench Testing





# High Power RF Testing of The Quartz Based DLA Structure (IV)

-----High Power Testing Setup at NRL

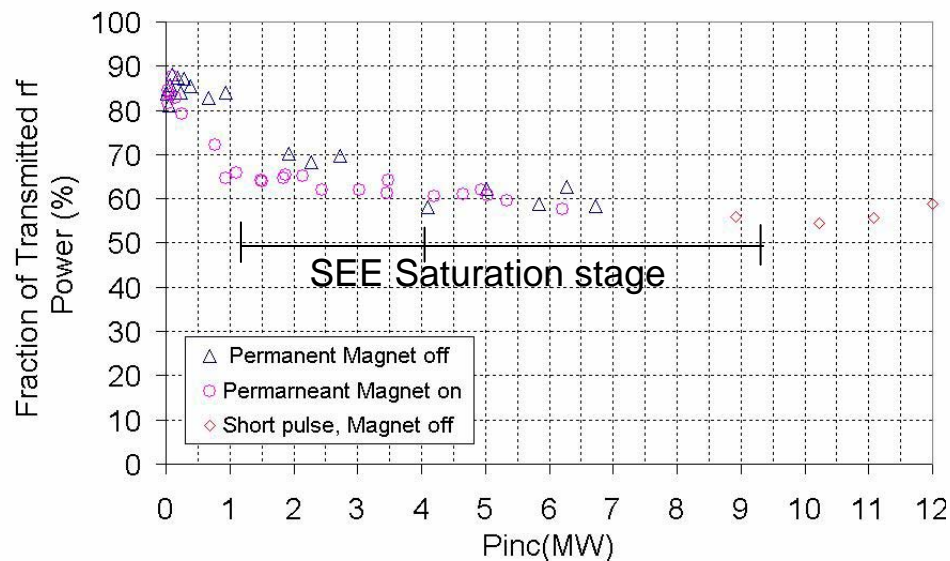


# High Power RF Testing of The Quartz Based DLA Structure (V)

----- Testing Results (i)

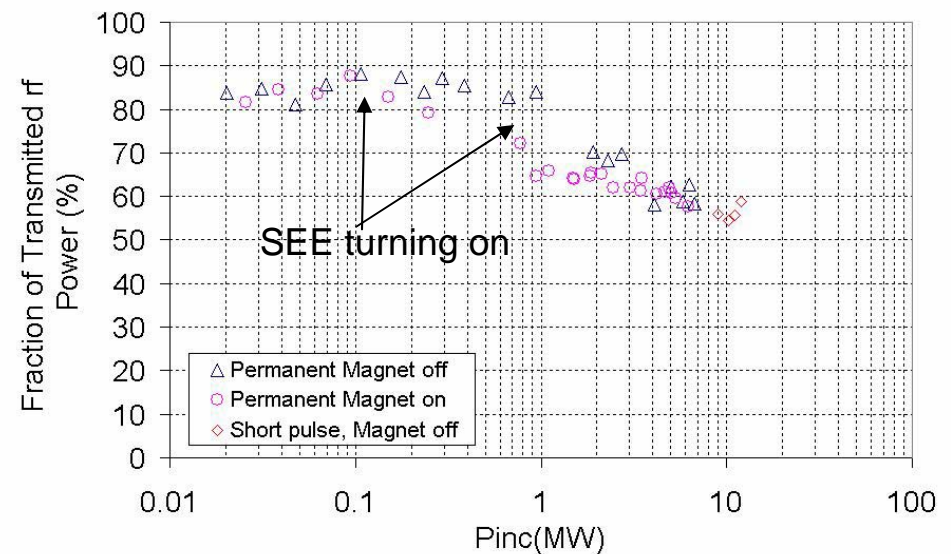
No breakdown up to ~5 MV/m  
Large multipactor again

High Power rf Testing of Quartz DLA



Linear scale

High Power rf Testing of Quartz DLA



Log scale

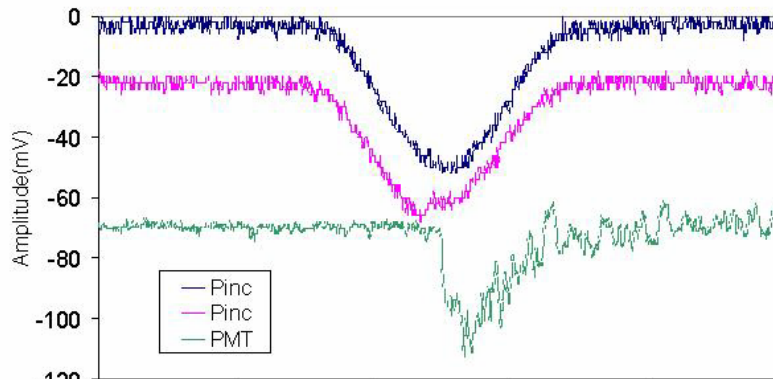




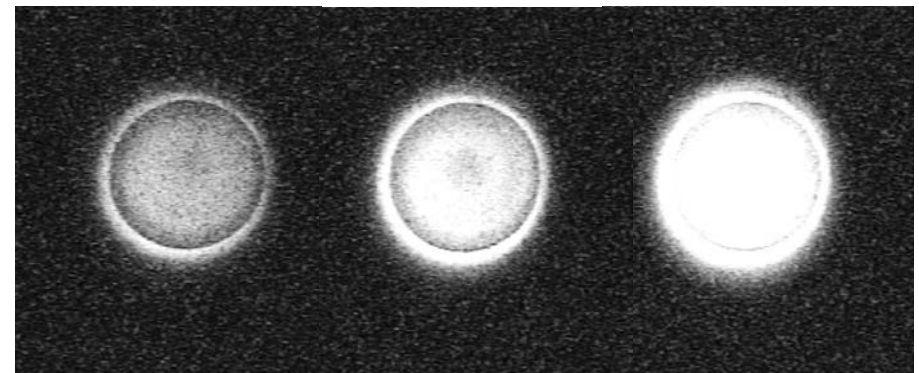
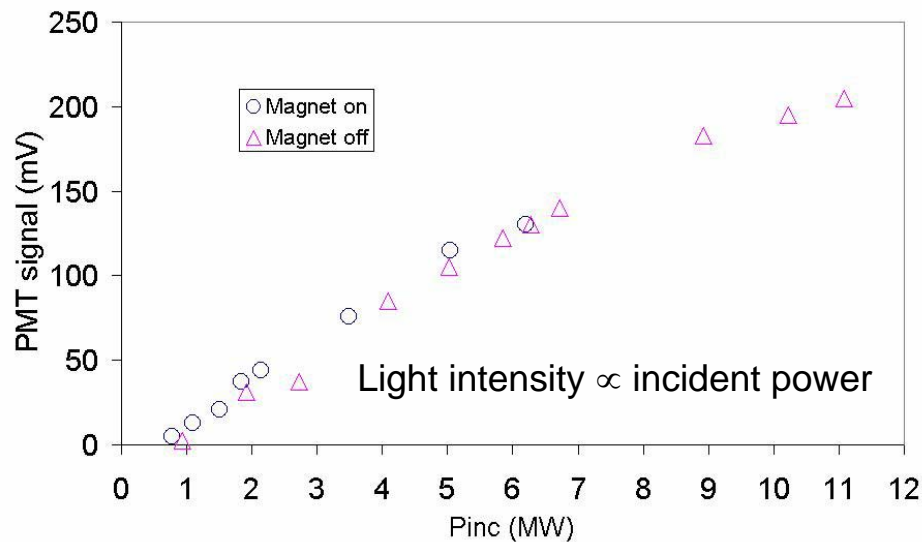
# High Power RF Testing of The Quartz Based DLA Structure (VI)

----- Testing Results (ii)

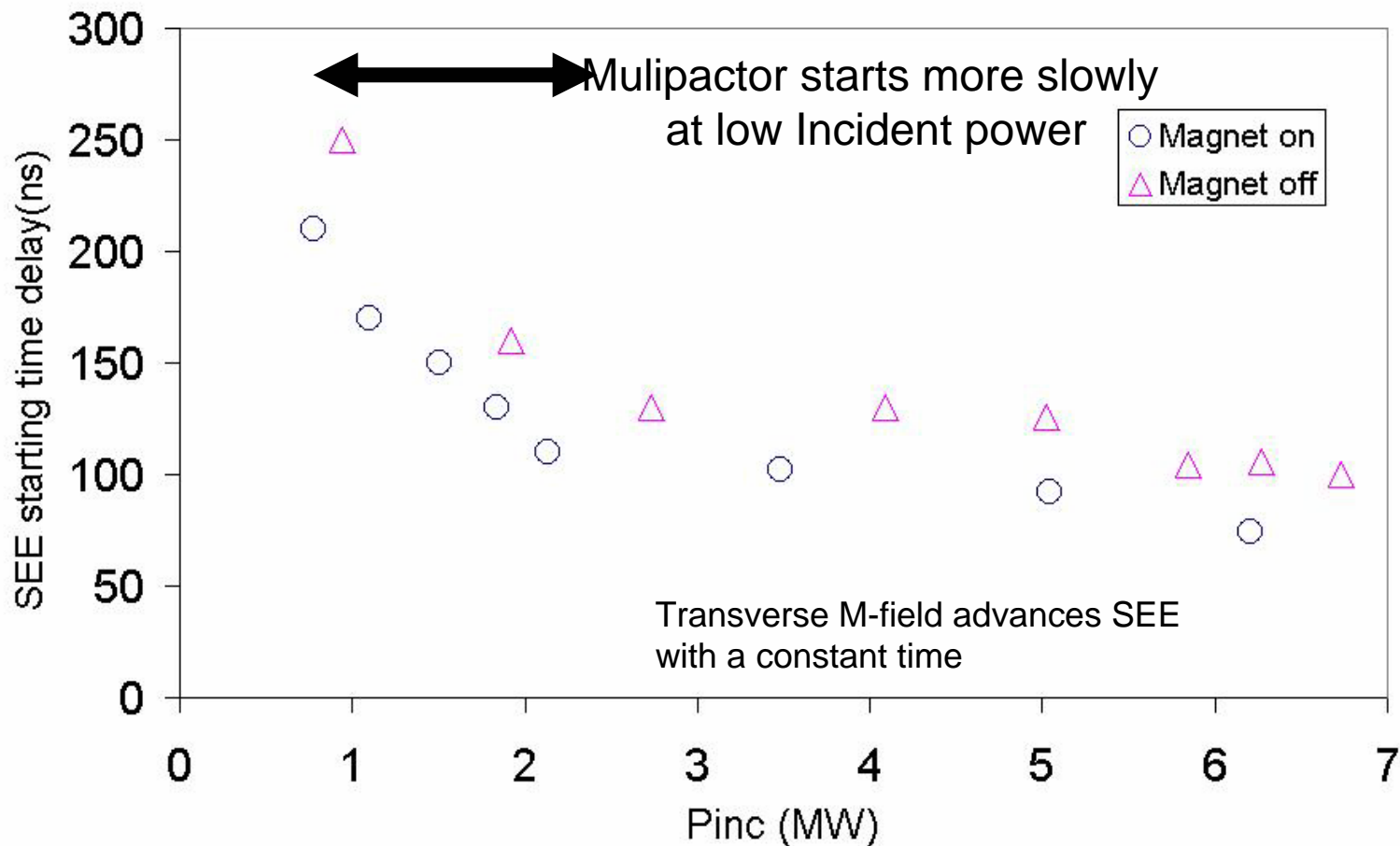
Using PMT to monitor Multipactor turning on



Incident rf vs. PMT signal



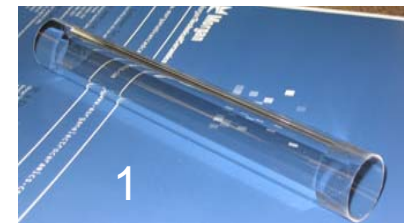
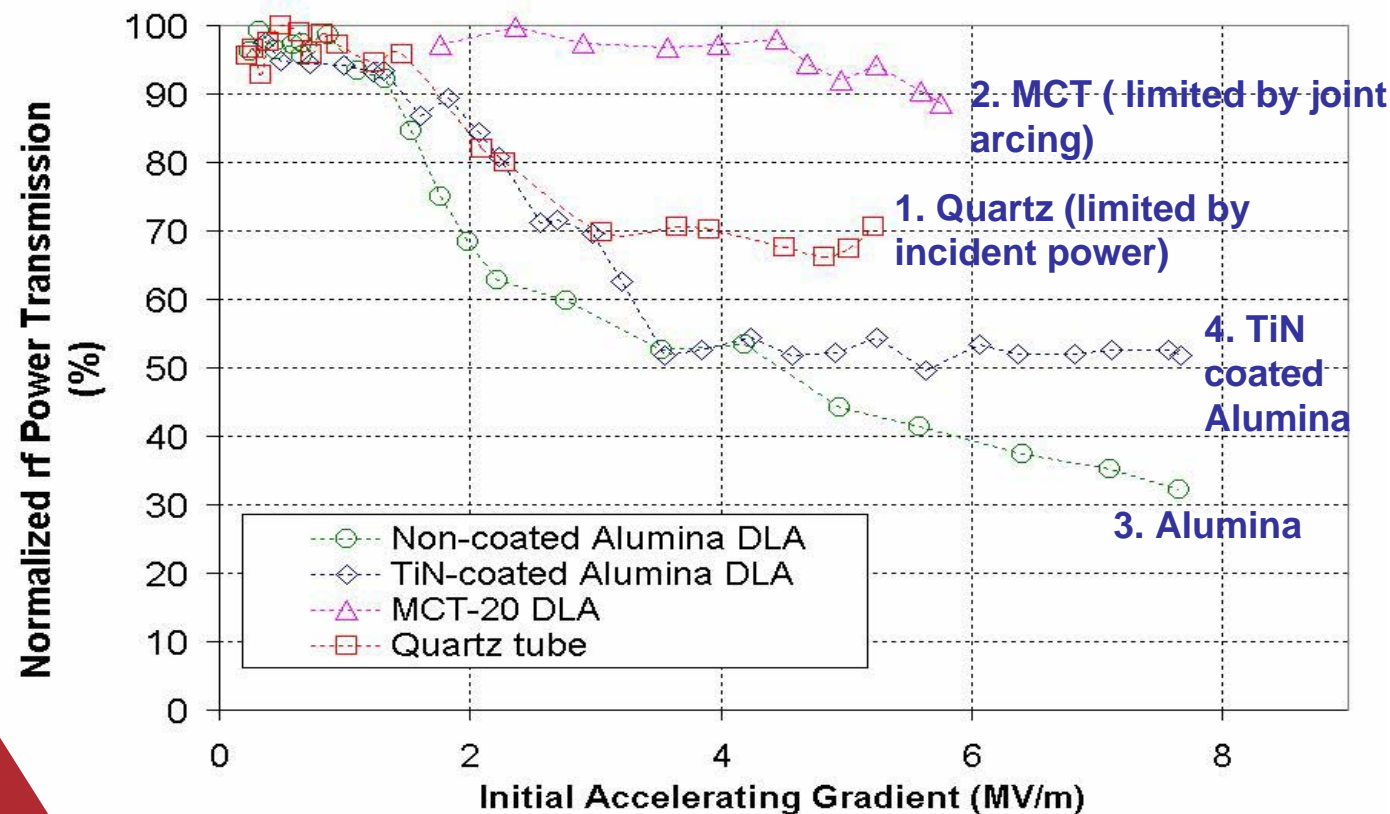
## Multipactor Turn-on time



# High Power RF Testing of The Quartz Based DLA Structure (VIII)

----- Comparison

- Dielectric Breakdown: Not seen in any structure
- Multipactor Induced Power Loss: lower in MCT and Quartz, saturate in Quartz and Al-TiN
- Joint Breakdown: >100 MV/m at joint in MCT;



# High Power RF Testing of The Quartz Based DLA Structure (IX)

----- Summary

## →DLA Progress to Date

- Four generations of couplers and structures designed and tested.
- Four different dielectric materials tested (Alumina, Fused Quartz, MCT, TiN coated Alumina)
- No Breakdown of the bulk dielectric observed (up to 8 MV/m)
- Multipactoring and joint breakdown discovered; developed schemes to suppress
- Gained fundamental understanding of the issues and developed new multipactoring theory.

## →DLA Future High Power Tests

- Joint-less DLA Structures (avoid joint breakdown)
- Small I.D. (Reduce Multipactor)
- Double Layer (Lower Power Attenuation)



## Part II

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1. The Recent High Power rf Testing of Quartz Based DLA Structure
2. Ways to Higher Gradient for DLA Structures
  - Small I.D. quartz DLA structure design: Test high gradient and multipactor power scaling
  - Gapless DLA structure based on the new coupler design
  - Low loss double layer DLA structure





# Small ID Quartz Based DLA structure design (I)

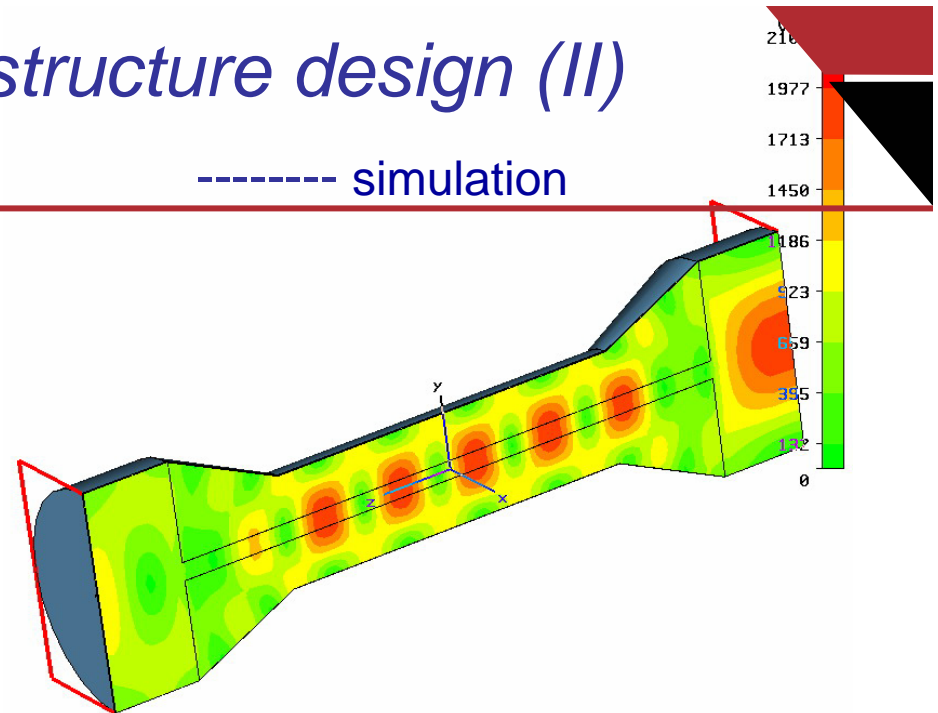
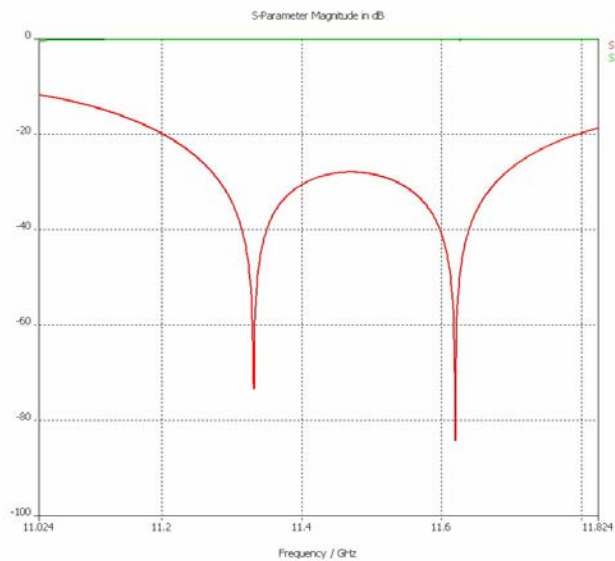
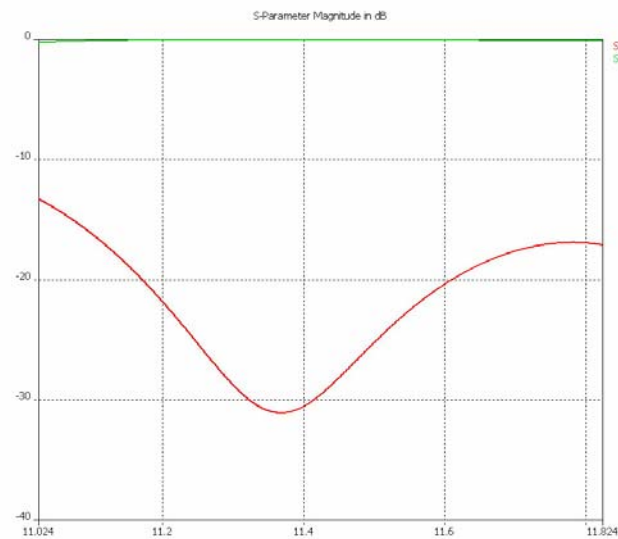
-----Parameters for different loaded materials

Loaded Material	dimensions	Group Velocity	Bandwidth (S11<-15dB)	Gradient per 10MW	Gradient per 100MW
Quartz ( $\epsilon=3.75$ )	ID=2mm OD=12.52mm	0.267c	480MHz	12.3MV/m	38.9MV/m
Cordierite ( $\epsilon=4.76$ )	ID=2mm OD=10.85mm	0.21c	350MHz	14.6MV/m	46.2MV/m
Alumina ( $\epsilon=9.77$ )	ID=3mm OD=8.23mm	0.1c	300MHz	19.8MV/m	62.6MV/m
MCT ( $\epsilon=20$ )	ID=3mm OD=6.42mm	0.05c	42MHz	26.5MV/m	83.8MV/m

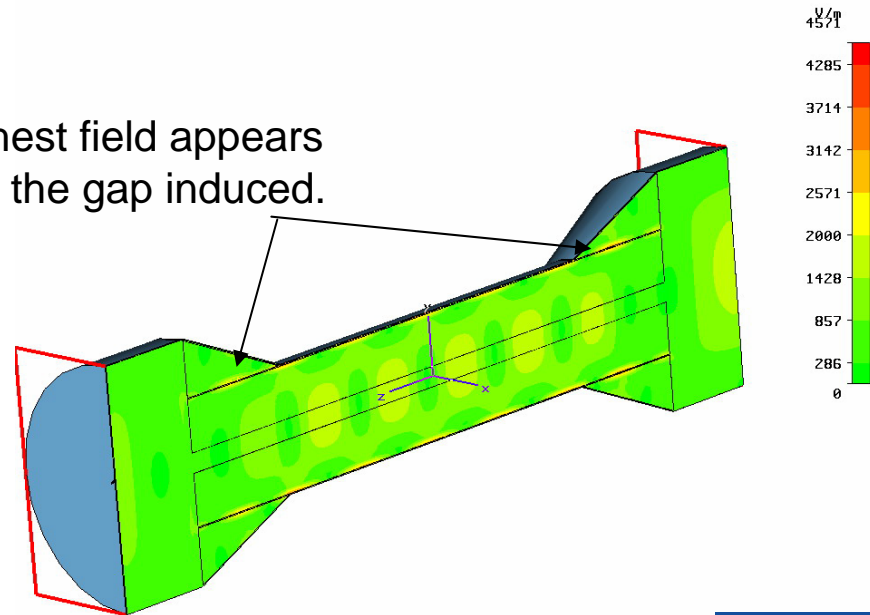


# Small ID Quartz Based DLA structure design (II)

----- simulation



Highest field appears with the gap induced.



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## Part II

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### 1. The Recent High Power rf Testing of Quartz Based DLA Structure

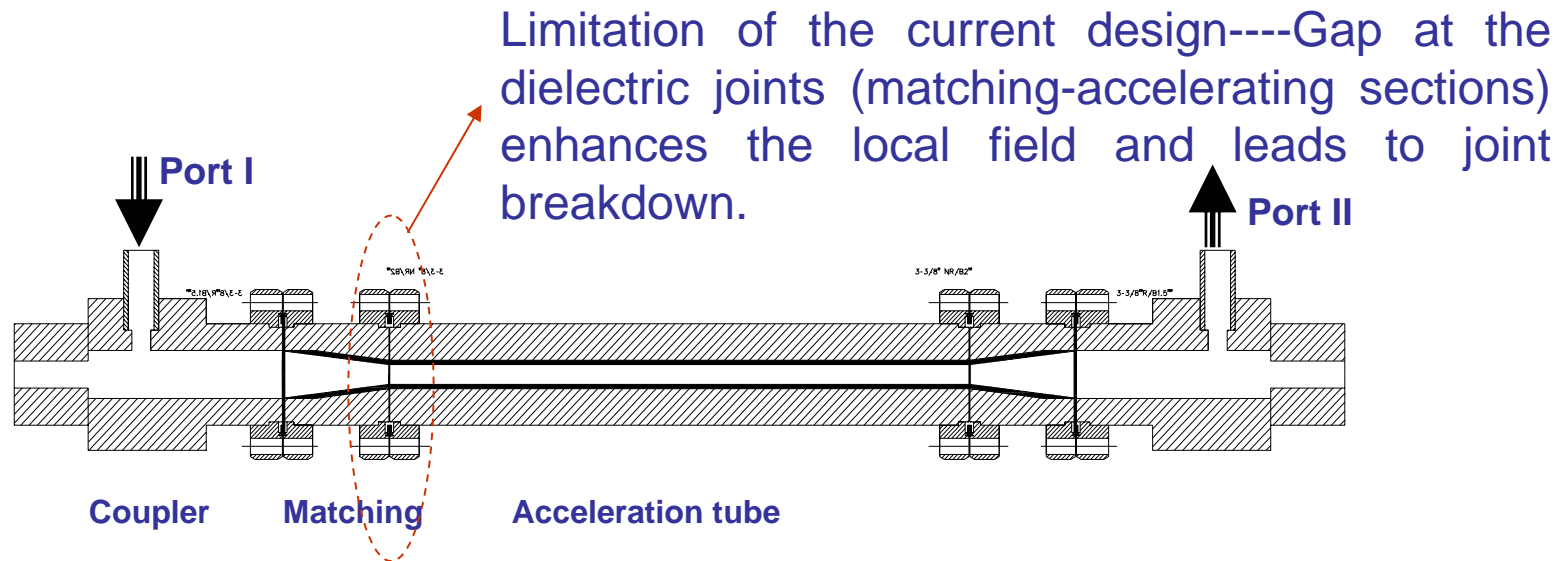
### 2. Ways to Higher Gradient for DLA Structures

- small I.D. quartz DLA structure design: Test high gradient and multipactor power scaling
- Gapless DLA structure based on the new coupler design
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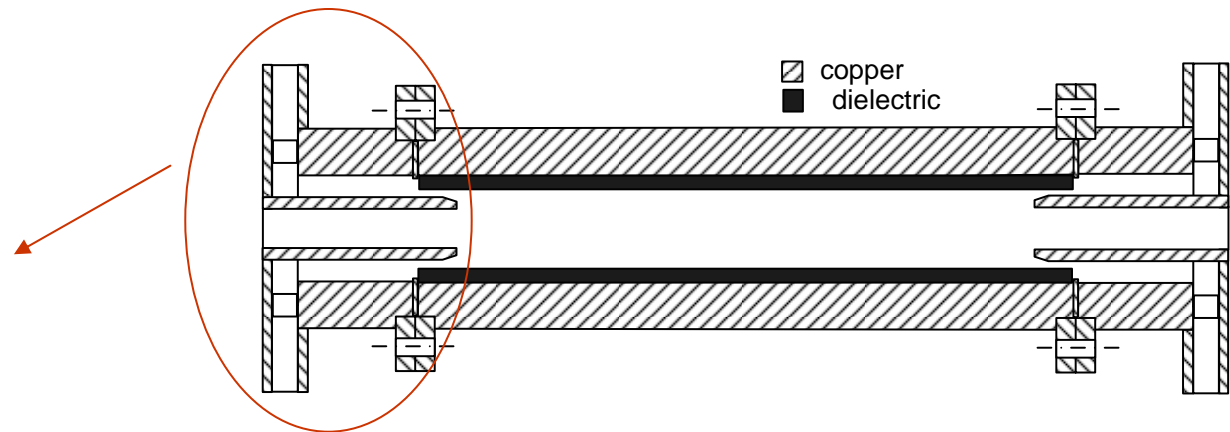


# Gapless DLA structure based on the new coupler design\* (I)

----- concept



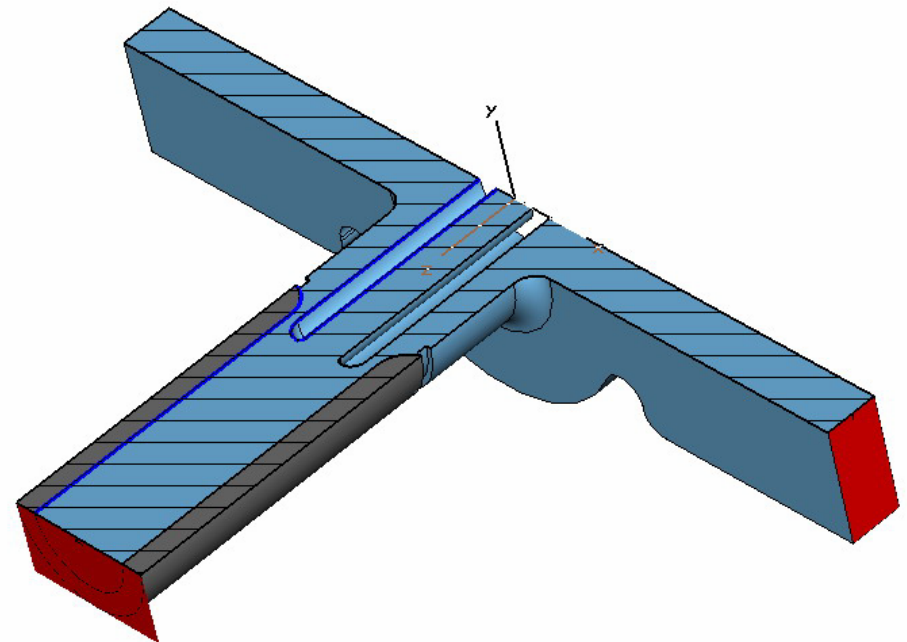
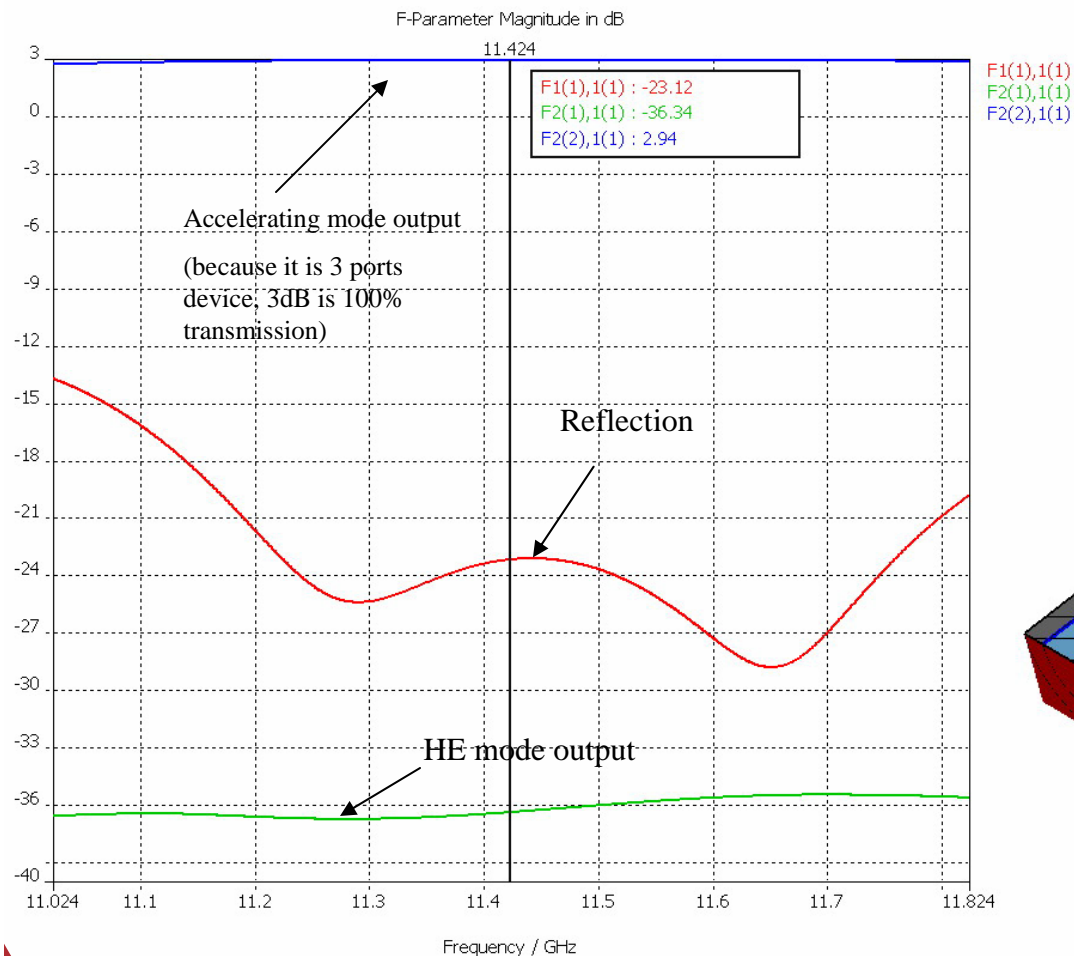
New design uses the coaxial coupler which eliminates the dielectric taper section in the current design



\* Funded by SBIR

# Gapless DLA structure based on the new coupler design (II)

----- coupler simulation

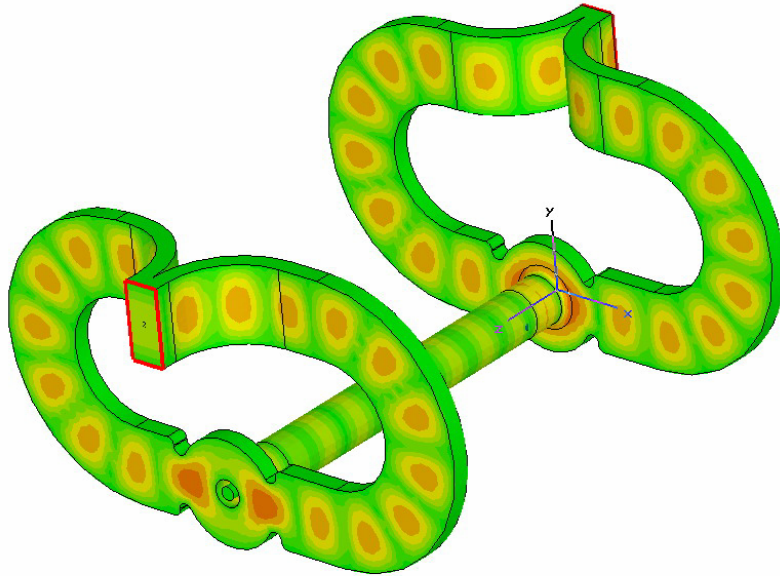


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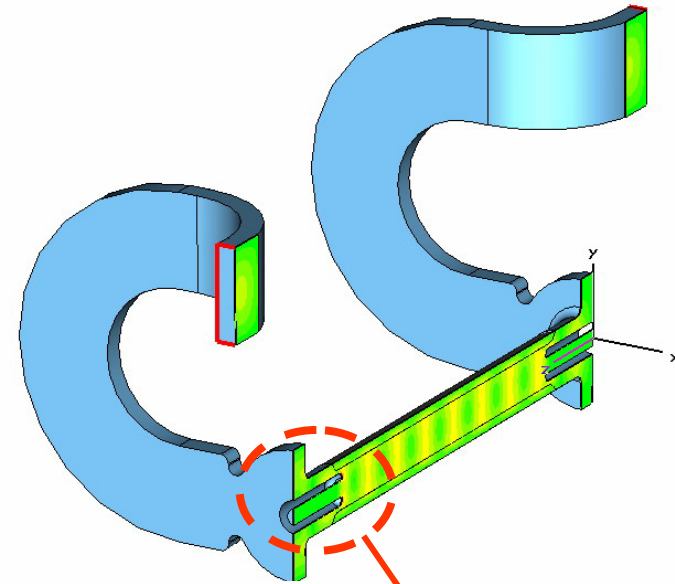


# Gapless DLA structure based on the new coupler design (III)

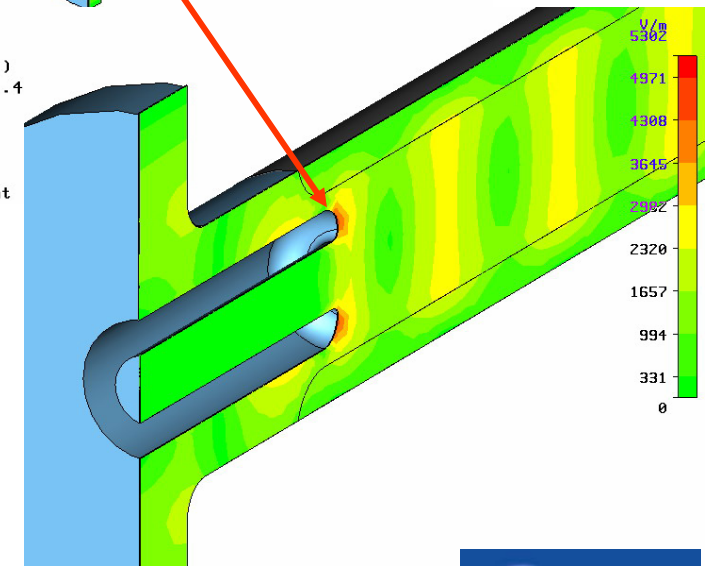
----- Structure simulation



Type = E-Field (peak)  
Monitor = e-field (f=11.424) [1]  
Component = Abs  
Maximum-3d = 5847.91 V/m at 3 / 0 / 21.37  
Frequency = 11.424  
Phase = 0 degrees



Type = E-Field (peak)  
Monitor = e-field (f=11.4  
Component = Abs  
Plane at x = -0.5  
Frequency = 11.424  
Phase = 90 degrees  
Maximum-2d = 5301.87 V/m at



- There is no dielectric gap in the structure.
- Highest E-field appears at inner conductor tip, but the field enhancement ratio has only 1.6 to the accelerating gradient.

## Part II

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### 1. The Recent High Power rf Testing of Quartz Based DLA Structure


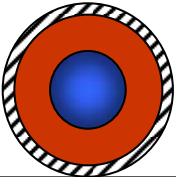
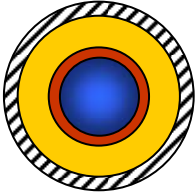
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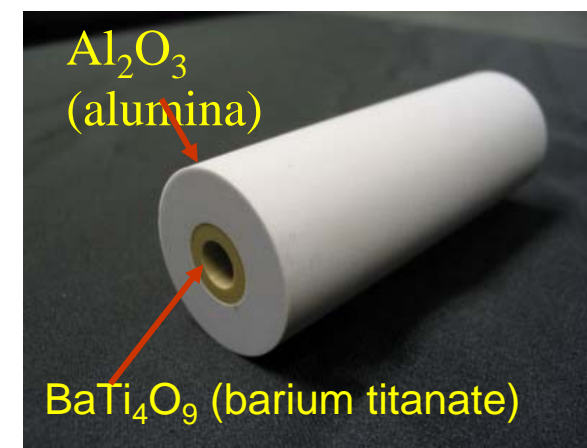
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# Low loss double layer DLA structure (I) ----- Concept

X-band Dual layer Dielectric-Loaded Accelerating Structure, funded by SBIR, is being developed at Euclid Techlabs, LLC in recent several months. So far, the entire targets proposed in Phase I plan have been accomplished which include fabrication of dual layer ceramic tube, simulation and fabrication of  $TM_{03}$  mode launcher and bench testing.

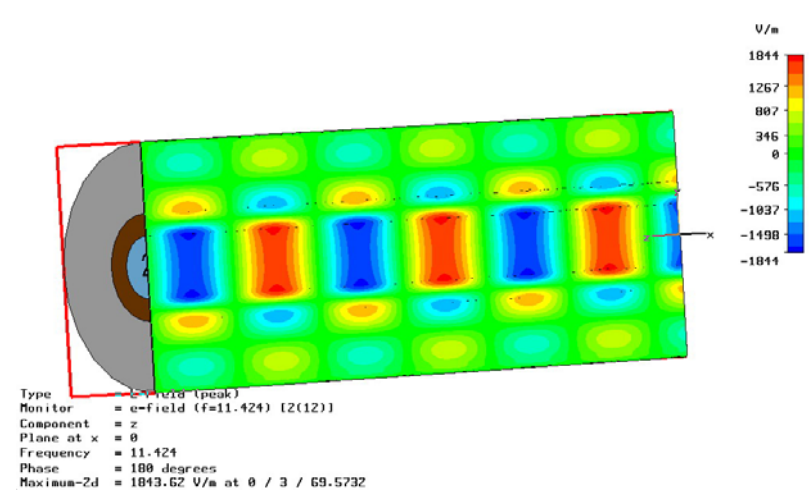
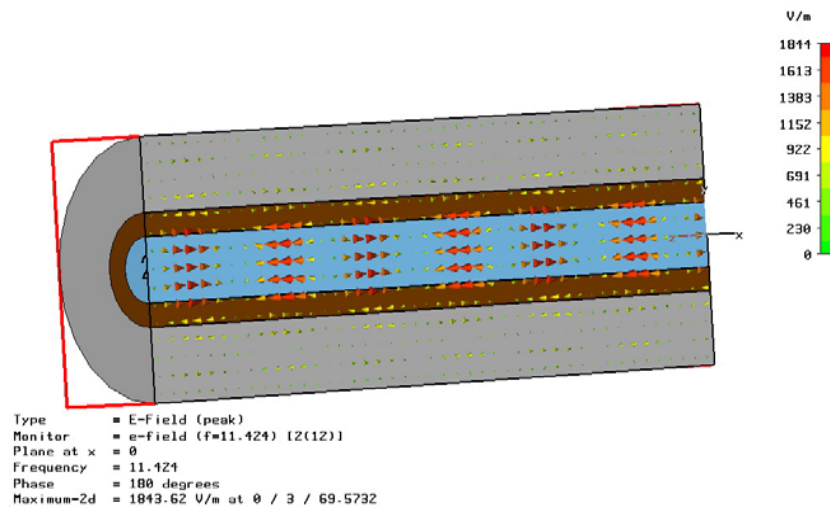
<div> <div></div> Ceramic with high permittivity (37) <div></div> Air <div></div> Ceramic with low permittivity (9.7) <div></div> Metal jacket </div>		Group velocity ( $\times c$ )	R ( $M\Omega/m$ )	R/Q ( $\Omega/m$ )	Power Attn (dB/m)
	1 layer DLA $TM_{01}$ mode IR:3—4.13mm	3%	11.7*	1681*	-20*
	1 layer DLA $TM_{03}$ mode IR:3—8.49mm	3%	7.4*	1553*	-7.8*
	2-layer DLA $TM_{03}$ Mode IR:3--5.17—12.02mm	6%	14.5*	2040*	-2.3*



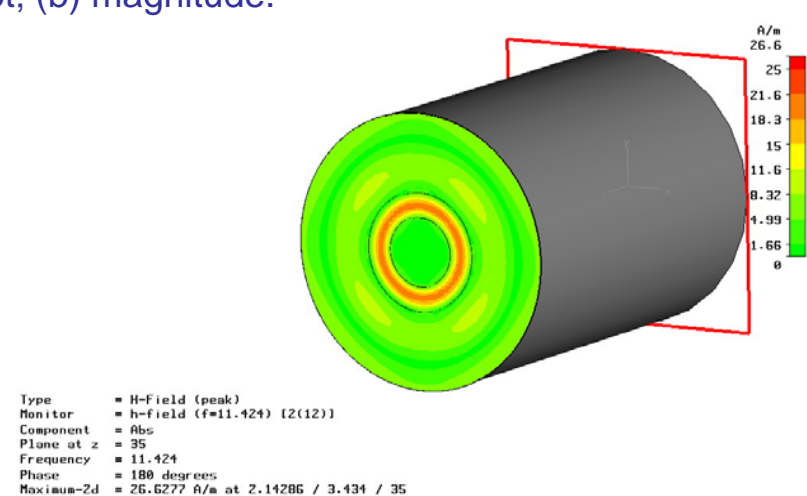
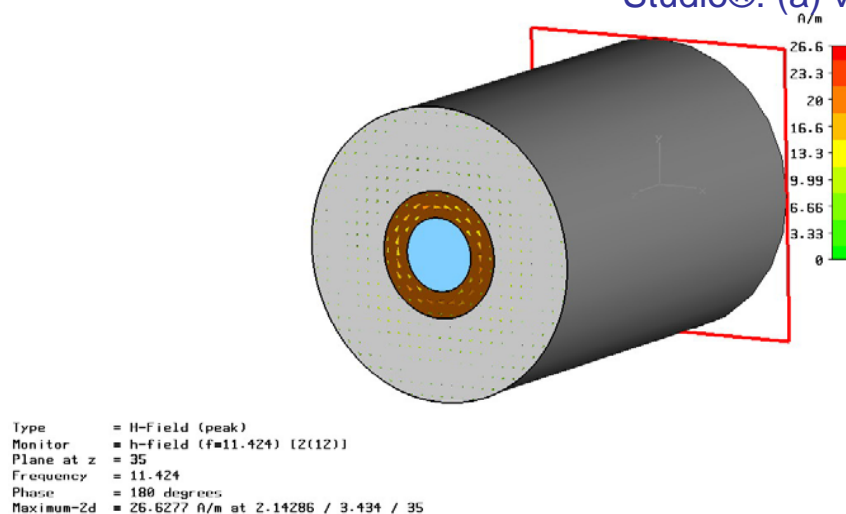
\* Based on loss tangent of  $10^{-4}$ .

# Low loss double layer DLA structure (II)

----- Field profile



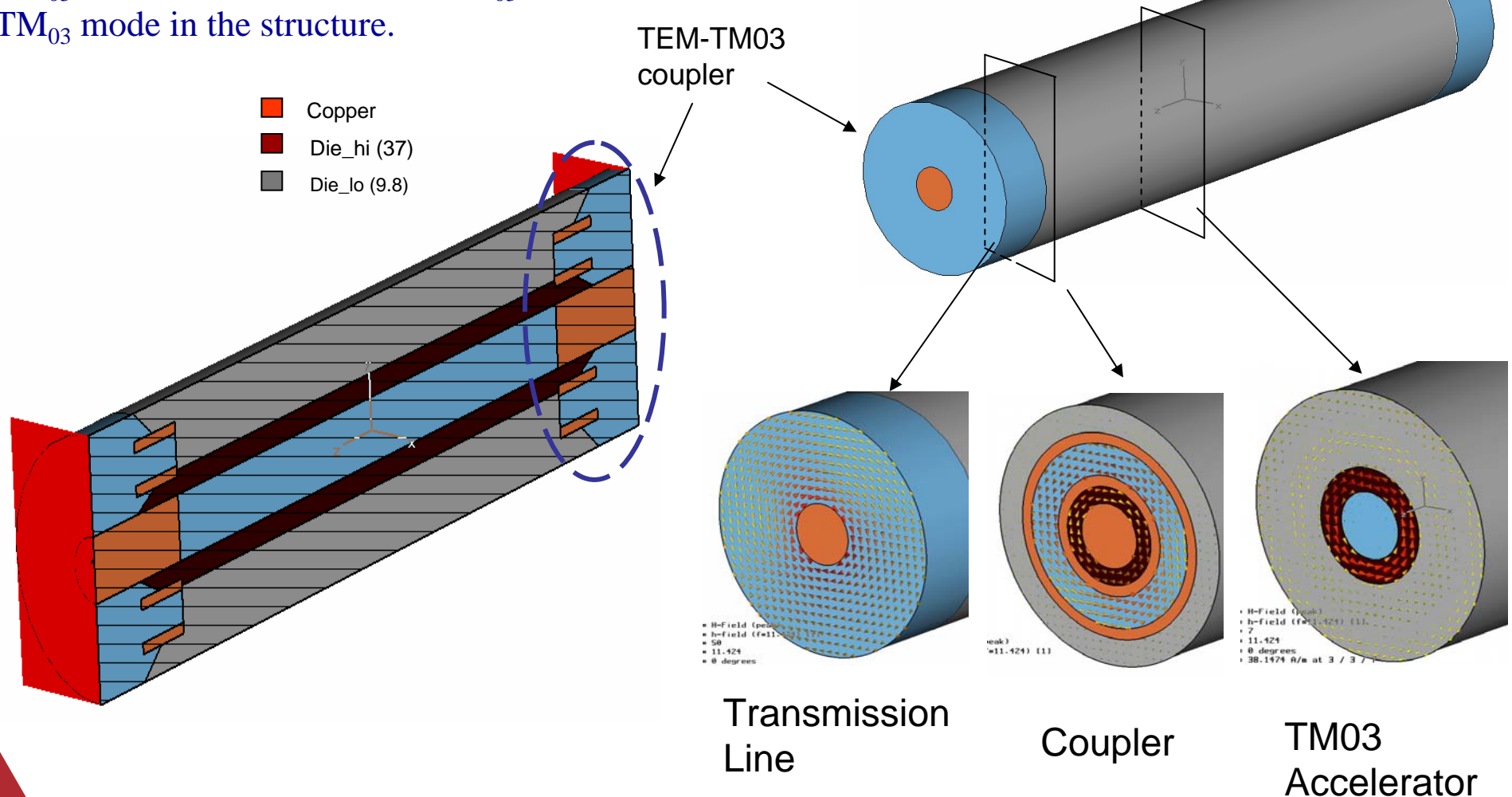
Electric field of dual layer DLA structure simulated with Microwave Studio®: (a) vector plot; (b) magnitude.



Magnetic field pattern of the double layer DLA structure simulated with Microwave Studio®: (a) vector plot; (b) magnitude.

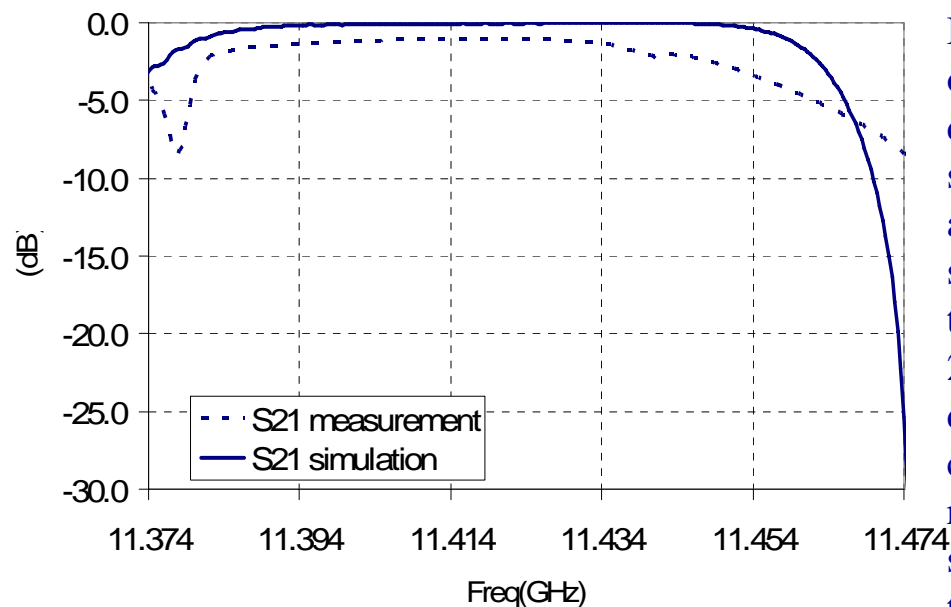
# Low loss double layer DLA structure (III) ---- $TM_{03}$ Mode Launcher

Because that the dual layer DLA structure is designed to operate at  $TM_{03}$  mode, we developed a  $TM_{03}$  mode launcher to only excite  $TM_{03}$  mode in the structure.

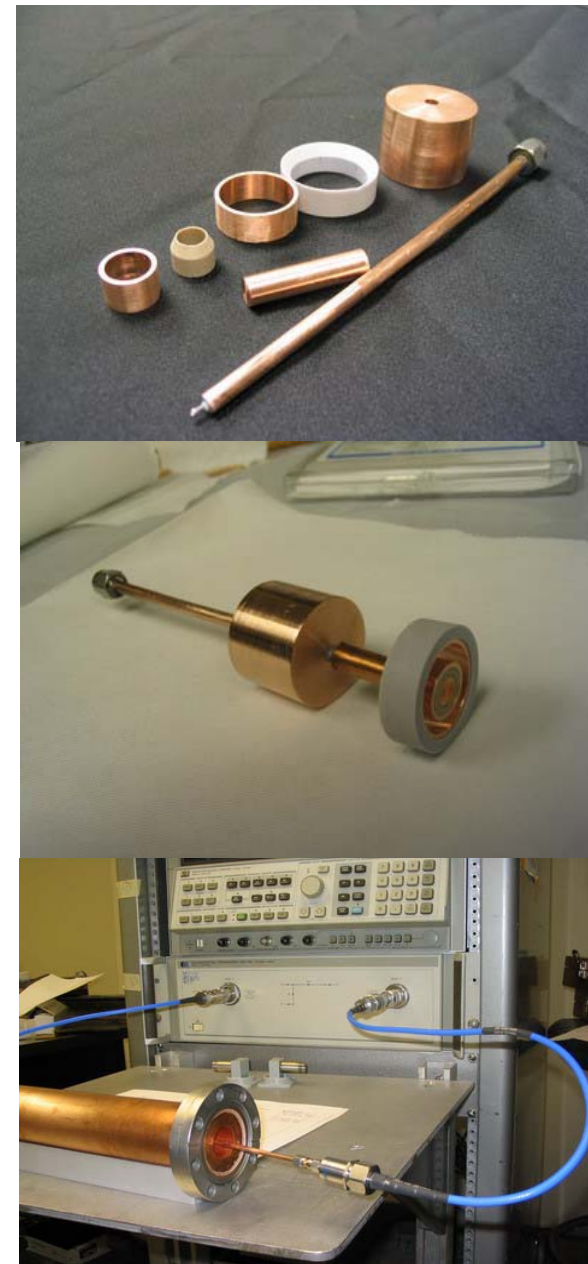
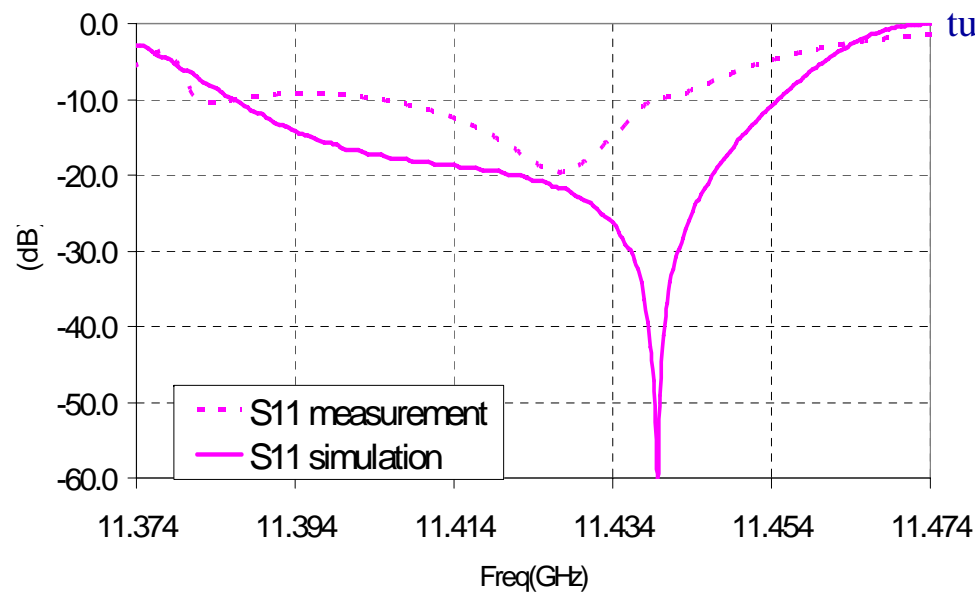




# Low loss double layer DLA structure (IV) ----- Bench Testing



Based on the results of bench testing, the dual layer DLA structure has 4dB/m attenuation, which is slightly larger than the theoretical value, 2.5dB/m. It is partly due to the larger copper loss from rough surface, and slightly higher loss tangent of ceramic tube.



## Summary

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- We have tested RF and multipactor behaviors of the quartz based DLA structure; 12MW rf power was input without breakdown; saturation stage of the multipactor appeared at 1MW rf input; the same structure will be tested with higher rf power.
- We are moving forward with some new DLA structures design to try to achieve a higher accelerating gradient and lower RF loss.

